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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/728,263	11/28/2000	H. Sam Bergh	99-1 CIP1DIV2	7497

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SYMYX TECHNOLOGIES INC
LEGAL DEPARTMENT
3100 CENTRAL EXPRESS
SANTA CLARA, CA 95051

EXAMINER

QUAN, ELIZABETH S

ART UNIT	PAPER NUMBER
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1743

DATE MAILED: 04/01/2005

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Serial No. : 09728263
Applicant : H. Sam Bergh
Filing Date : November 28, 2000
Date Mailed : April 1, 2005

ACKNOWLEDGEMENT OF REQUEST

Notice of Allowance/Allowability Mailed

The request for a copy of the initialed PTO 1449, dated April 29, 2004, has been received by the U.S. Patent and Trademark Office.

- Requested copy attached.

A handwritten signature in blue ink, appearing to read "Sunda M. Archer", written over a horizontal line.

SUNDA M. ARCHER
For the Office of Patent Publication



INFORMATION DISCLOSURE CITATION PTO-1449	ATTORNEY'S DOCKET NO.: 99-1CIP1D	APPLICATION NO.: 09/728,263
	APPLICANT: Bergh, et al.	
	FILING DATE: 11/28/2000	GROUP: 1764

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US PATENT DOCUMENTS

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	6,086,740	7/11/00	Kennedy	284	601	10/29/88
DB	6,071,478	6/6/00	Chow	422	81	2/2/99
	3,797,202	3/19/74	Neulander et al.	55	158	8/27/71
	4,386,505	6/7/83	Little	62	514 R	3/4/82
	4,392,362	7/12/83	Little	62	514 R	5/1/81
	4,516,632	5/14/85	Swift et al.	165	167	8/31/82
	5,016,707	5/21/91	Nguyen	165	167	12/28/89
	5,145,579	9/8/92	Eguchi et al.	210	198.2	9/16/91
	5,209,906	5/11/93	Watkins et al.	422	200	5/10/91
	5,230,866	7/27/93	Shartie et al.	422	103	3/1/91
	5,296,775	3/22/94	Cronin et al.	310	309	9/24/92
	5,354,460	10/11/94	Keamey et al.	210	198.2	1/28/93
	5,385,712	1/31/95	Sprunk	422	190	12/7/93
	5,388,635	2/14/95	Gruber et al.	165	80.4	5/8/92
	5,580,523	12/3/96	Bard	422	50	4/1/94
	5,587,128	12/24/96	Wilding et al.	422	50	11/14/94
	5,611,214	3/18/97	Wegeng et al.	62	498	7/29/94
	5,639,423	6/17/97	Northrup et al.	122	50	8/31/92
	5,658,413	8/18/97	Kaltenbach et al.	156	272.8	6/7/95
	5,699,157	12/16/97	Parce	356	344	7/16/96
	5,852,495	12/22/98	Parce	356	344	9/30/97
	5,858,195	1/12/99	Ramsey	204	601	
	5,869,004	2/9/99	Parce et al.	422	100	6/9/97
	5,908,552	6/1/99	Dittmann et al.	210	198.2	10/10/97
	5,942,443	8/24/99	Parce et al.	438	514	6/28/98
	5,948,227	9/7/99	Dubrow	204	455	12/17/97
	5,955,028	9/21/99	Chow	422	63	8/14/97
	5,957,579	9/28/99	Kopf-Sill et al.	368	340	9/30/98
	5,965,001	10/12/99	Chow et al.	204	600	7/3/97

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INFORMATION DISCLOSURE CITATION PTO-1449	ATTORNEY'S DOCKET NO.: 99-1CIP1DIV2	APPLICATION NO.: 09/728,263
	APPLICANT: Bergh, et al.	
	FILING DATE: 11/28/00	GROUP: 1764

US PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
ER	5,865,410	10/12/99	Chow et al.	435	81.2	11/25/97
	5,976,338	11/2/99	Dubrow et al.	204	453	4/25/97
	5,989,402	11/23/99	Chow et al.	204	601	8/29/97
	6,001,229	12/14/99	Ramsey	204	451	8/1/94
	6,004,515	12/21/99	Parce et al.	422	100	10/27/98
	6,010,607	1/4/00	Ramsey	204	435	9/16/98
	6,010,608	1/4/00	Ramsey	204	453	9/16/98
	6,042,709	3/28/00	Parce et al.	204	453	11/24/98
	6,042,710	3/28/00	Dubrow	204	454	5/11/99
	6,046,056	4/4/00	Parce et al.	438	514	12/8/98
	6,068,684	5/30/00	Overton	98	104	9/11/97
	6,068,752	5/30/00	Dubrow et al.	204	604	8/11/99
	6,074,725	6/13/00	Kennedy	428	188	12/10/97
	6,087,180	7/11/00	Gleaves	436	37	10/28/98
	6,100,541	8/8/00	Nagle et al.	250	573	2/24/98
	6,123,798	9/26/00	Gandhi et al.	156	282	5/6/98
	6,132,685	10/17/00	Kercso et al.	422	104	8/10/98

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INFORMATION DISCLOSURE
CITATION

PTO-1449

ATTORNEY'S DOCKET NO.:

99-1CIP1DIV2

APPLICATION NO.:

09/728,263

APPLICANT:

Bergh, et al.

FILING DATE:

11/28/00

GROUP:

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EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION ?	FILING DATE
PK	WO 99/64836	12/16/99	PCT	G01N 1/10	No	8/7/99
	WO 00/45172	8/3/00	PCT	G01N 33/558	No	1/28/00
	GB 2 327 754	2/3/99	United Kingdom	G01N 31/10	No	7/26/97
	WO 99/56956	12/17/98	PCT	C12Q 1/70	No	6/9/98
	WO 99/10221	1/14/99	PCT	B01L 3/00	No	6/29/98
	WO 99/30817	6/24/99	PCT	B01J 19/00	No	12/15/97
	WO 99/34205	7/8/99	PCT	G01N 30/86	No	12/29/98
	WO 99/43432	9/2/99	PCT	B01L 3/00 G01N 27/26, 27/447	No	2/23/99
	WO 99/59716	11/25/99	PCT	B01J 19/00	Yes	6/12/99
	WO 99/64160	12/16/99	PCT	B01L 3/02, 3/00 // B01J 19/00	No	6/2/99
	WO 00/22424	4/20/00	PCT	G01N 27/26, 27/447	No	10/12/99
	WO 0042212	7/20/00	PCT	C12Q 1/00, 1/26, G01N 33/53, 33/567	No	1/18/00
	WO 00/43766	7/27/00	PCT	G01N 27/26	No	1/19/00
	WO 00/46594	8/10/00	PCT	G01N 27/26	No	2/2/00
	WO 00/50172	8/31/00	PCT	B01L 3/100, C12Q 1/68	No	2/22/00
	WO 00/07026	2/10/00	PCT	G01N 35/00, E21B 49/00	No	7/26/99
	WO 01/12327	2/22/01	PCT	B01L 3/00	No	8/10/00
	WO 96/35810	11/14/96	PCT	C12Q 1/68, 1/70	No	5/9/96
	WO 99/19724	4/22/99	PCT	G01N 31/10	No	10/8/98
	WO 00/32512	6/8/00	PCT	C01B 3/50, B01D 71/02, B01J 19/00	No	12/2/99
	WO 00/32308	6/8/00	PCT	B01J 19/00	No	12/3/99
	WO 99/48599	9/30/99	PCT	B01F 5/06	No	3/22/99
	WO 96/15576	5/23/96	PCT	H02K 44/02	No	11/9/95
	WO 00/21666	4/20/00	PCT	B01L 3/02	No	10/12/99
	EP 971 225	1/12/00	EP	G01N 21/17	Yes	7/7/99

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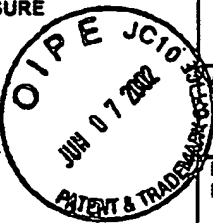
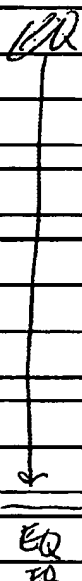
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BQ	3,431,077	3/4/69	Danforth	23	253	7/18/66
	4,099,923	7/11/78	Milberger	23	254	1/17/77
	4,832,914	5/23/89	Tam et al.	422	130	2/8/88
	5,089,232	2/18/92	May	422	83	1/24/90
	5,304,354	4/19/94	Finley et al.	422	196	11/30/92
	5,356,756	10/18/94	Cavicchi, et al.	430	315	10/26/92
	5,534,328	7/9/96	Ashmead et al.	428	166	12/2/93
	5,593,642	1/14/97	DeWitt et al.	422	131	6/5/95
	5,603,351	2/18/97	Cherukuri et al.	137	597	6/7/95
	5,690,763	11/25/97	Ashmead et al.	156	60	6/6/95
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	DD 234 941 A1		Germany		No	
BQ	DE 196 32 779 A1		Germany	G01N 35/00	Yes	
	DE 198 05 719 A1		Germany	B01J 35/04	Yes	
	DE 198 06 848 A1		Germany	B01J 35/02	Yes	
	DE 198 09 477 A1	9/16/99	Germany	G01N 31/10	Yes	3/6/98
	DE 198 55 894 A1		Germany	B01J 35/04	No	
	DE 27 14 939 B2		Germany		No	
BQ	WO 00/14529	3/16/00	WIPO	G01N 31/02	No	9/3/99
	WO 97/32208	9/4/97	WIPO	G01N 31/10	No	2/25/97
	WO 98/07206	02/19/98	WIPO	G01N 31/10	Yes	8/12/97
	WO 98/16949	4/23/98	WIPO	H01J 49/40	Yes (Even pages only)	9/26/97
	WO 99/41005	8/19/99	WIPO	B01J 19/00	Yes	2/11/99

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